## CMF10120D-Silicon Carbide Power MOSFET Z-FET ${ }^{T M}$ MOSFET <br> N -Channel Enhancement Mode

## Features

- High Speed Switching with Low Capacitances
- High Blocking Voltage with Low $\mathrm{R}_{\mathrm{DS}(o n)}$
- Easy to Parallel and Simple to Drive
- Avalanche Ruggedness
- Resistant to Latch-Up
- Halogen Free, RoHS Compliant


## Benefits

- Higher System Efficiency
- Reduced Cooling Requirements
- Increased System Switching Frequency


## Applications

- Solar Inverters
- High Voltage DC/DC Converters
- Motor Drives
- Switch Mode Power Supplies


## Package


$=1200 \mathrm{~V}$
$=24 \mathrm{~A}$
$=160 \mathrm{~m} \Omega$

| $\mathbf{V}_{\mathrm{DS}}$ | $=1200 \mathrm{~V}$ |
| :--- | :--- |
| $\mathbf{I}_{\mathrm{D}(\text { MAX })}$ | $=24 \mathrm{~A}$ |
| $\mathbf{R}_{\mathrm{DS}(\text { on })}$ | $=160 \mathrm{~m} \Omega$ |

TO-247-3


| Part Number | Package |
| :---: | :---: |
| CMF10120D | TO-247-3 |

Maximum Ratings ( $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ unless otherwise specified)

| Symbol | Parameter | Value | Unit | Test Conditions | Note |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{I}_{\text {D }}$ | Continuous Drain Current | 24 | A | $\mathrm{V}_{\mathrm{GS}} @ 20 \mathrm{~V}, \mathrm{~T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | Fig. 10 |
|  |  | 13 |  | $\mathrm{V}_{\mathrm{GS}} @ 20 \mathrm{~V}, \mathrm{~T}_{\mathrm{C}}=100^{\circ} \mathrm{C}$ |  |
| $I_{\text {Dpulse }}$ | Pulsed Drain Current | 49 | A | Pulse width $t_{p}$ limited by $T_{\text {jmax }}$ $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ |  |
| $\mathrm{E}_{\text {AS }}$ | Single Pulse Avalanche Energy | 1.2 | J | $\begin{aligned} & \mathrm{I}_{\mathrm{D}}=10 \mathrm{~A}, \mathrm{~V}_{\mathrm{DD}}=50 \mathrm{~V}, \\ & \mathrm{~L}=20 \mathrm{mH} \end{aligned}$ <br> $\mathrm{t}_{\mathrm{AR}}$ limited by $\mathrm{T}_{\text {jmax }}$ | Fig. 15 |
| $\mathrm{E}_{\text {AR }}$ | Repetitive Avalanche Energy | 0.8 | J |  |  |
| $\mathrm{I}_{\text {AR }}$ | Repetitive Avalanche Current | 10 | A | $\begin{aligned} & \mathrm{I}_{\mathrm{D}}=10 \mathrm{~A}, \mathrm{~V}_{\mathrm{DD}}=50 \mathrm{~V}, \mathrm{~L}=15 \mathrm{mH} \\ & \mathrm{t}_{\mathrm{AR}} \text { limited by } \mathrm{T}_{\mathrm{jmax}} \end{aligned}$ |  |
| $\mathrm{V}_{\text {GS }}$ | Gate Source Voltage | $-5 /+25$ | V |  |  |
| $\mathrm{P}_{\text {tot }}$ | Power Dissipation | 134 | W | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | Fig. 9 |
| $\mathrm{T}_{\mathrm{j}}, \mathrm{T}_{\text {stg }}$ | Operating Junction and Storage Temperature | $\begin{gathered} -55 \text { to } \\ +135 \end{gathered}$ | ${ }^{\circ} \mathrm{C}$ |  |  |
| $\mathrm{T}_{\mathrm{L}}$ | Solder Temperature | 260 | ${ }^{\circ} \mathrm{C}$ | $1.6 \mathrm{~mm}\left(0.063^{\prime \prime}\right)$ from case for 10 s |  |
| $M_{\text {d }}$ | Mounting Torque | $\begin{gathered} 1 \\ 8.8 \end{gathered}$ | $\underset{\text { Ibf-in }}{\mathrm{Nm}}$ | M3 or 6-32 screw |  |

Electrical Characteristics ( $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ unless otherwise specified)

| Symbol | Parameter | Min. | Typ. | Max. | Unit | Test Conditions | Note |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {(BR) }{ }^{\text {ds }}}$ | Drain-Source Breakdown Voltage | 1200 |  |  | V | $\mathrm{V}_{G S}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=50 \mu \mathrm{~A}$ |  |
| $\mathrm{V}_{\text {GS( }}$ (h) | Gate Threshold Voltage |  | 2.4 | 3.5 | V | $\mathrm{V}_{\mathrm{DS}}=\mathrm{V}_{\mathrm{GS}}, \mathrm{I}_{\mathrm{D}}=0.5 \mathrm{~mA}$ | Fig. 11 |
|  |  |  | 3.1 | 4.1 |  | $\mathrm{V}_{\mathrm{DS}}=\mathrm{V}_{G S}, \mathrm{I}_{\mathrm{D}}=1.0 \mathrm{~mA}$ |  |
|  |  |  | 1.8 |  | V | $\mathrm{V}_{\mathrm{DS}}=\mathrm{V}_{\mathrm{GS}}, \mathrm{I}_{\mathrm{D}}=0.5 \mathrm{~mA}, \mathrm{~T}_{3}=135^{\circ} \mathrm{C}$ |  |
|  |  |  | 2.3 |  | V | $\mathrm{V}_{\mathrm{DS}}=\mathrm{V}_{\mathrm{GS}}, \mathrm{I}_{\mathrm{D}}=1.0 \mathrm{~mA}, \mathrm{~T}_{\mathrm{J}}=135^{\circ} \mathrm{C}$ |  |
| Idss | Zero Gate Voltage Drain Current |  | 0.5 | 50 | $\mu \mathrm{A}$ | $\mathrm{V}_{\mathrm{DS}}=1200 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ |  |
|  |  |  | 5 | 150 |  | $\mathrm{V}_{\text {DS }}=1200 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{~T}_{J}=135^{\circ} \mathrm{C}$ |  |
| $\mathrm{I}_{\text {GSS }}$ | Gate-Source Leakage Current |  |  | 0.25 | $\mu \mathrm{A}$ | $\mathrm{V}_{G S}=20 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=0 \mathrm{~V}$ |  |
| $\mathrm{R}_{\mathrm{DS} \text { (on) }}$ | Drain-Source On-State Resistance |  | 160 | 200 | $\mathrm{m} \Omega$ | $\mathrm{V}_{G S}=20 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=10 \mathrm{~A}$ | Fig. 3 |
|  |  |  | 190 | 240 |  | $\mathrm{V}_{G S}=20 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=10 \mathrm{~A}, \mathrm{~T}_{J}=135^{\circ} \mathrm{C}$ |  |
| $\mathrm{gfs}^{\text {f }}$ | Transconductance |  | 4.2 |  | S | $\mathrm{V}_{\mathrm{DS}}=20 \mathrm{~V}, \mathrm{I}_{\mathrm{DS}}=10 \mathrm{~A}$ | Fig. 6 |
|  |  |  | 3.9 |  |  | $V_{D S}=20 \mathrm{~V}, \mathrm{I}_{\text {DS }}=10 \mathrm{~A}, \mathrm{~T}_{\mathrm{J}}=135^{\circ} \mathrm{C}$ |  |
| $\mathrm{C}_{\text {iss }}$ | Input Capacitance |  | 928 |  | pF | $\begin{aligned} & V_{G S}=0 \mathrm{~V} \\ & V_{D S}=800 \mathrm{~V} \\ & f=1 \mathrm{MHz} \\ & V_{A C}=25 \mathrm{mV} \end{aligned}$ | Fig. 13 |
| Coss | Output Capacitance |  | 63 |  |  |  |  |
| $\mathrm{Crss}^{\text {s }}$ | Reverse Transfer Capacitance |  | 7.5 |  |  |  |  |
| Eoss | Coss Stored Energy |  | 32 |  | $\mu \mathrm{J}$ |  | Fig 14 |
| $\mathrm{t}_{\text {d(on) }}$ | Turn-On Delay Time |  | 8.8 |  | ns | $\begin{aligned} & \mathrm{V}_{\mathrm{DD}}=800 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 / 20 \mathrm{~V} \\ & \mathrm{I}_{\mathrm{D}}=10 \mathrm{~A} \\ & \mathrm{R}_{\mathrm{G}(\text { ext })}=2.5 \Omega, \mathrm{R}_{\mathrm{L}}=40 \Omega \\ & \text { Timing relative to } \mathrm{V}_{\mathrm{DS}} \end{aligned}$ | fig. 17 |
| $\mathrm{t}_{\mathrm{v}}$ | Fall Time |  | 21 |  |  |  |  |
| $\mathrm{t}_{\text {d(off) })}$ | Turn-Off Delay Time |  | 38 |  |  |  |  |
| $\mathrm{t}_{\mathrm{rv}}$ | Rise Time |  | 34 |  |  |  |  |
| $\mathrm{R}_{\text {G }}$ | Internal Gate Resistance |  | 13.6 |  | $\Omega$ | $\mathrm{f}=1 \mathrm{MHz}, \mathrm{V}_{\mathrm{AC}}=25 \mathrm{mV}$ |  |

## Built-in SiC Body Diode Characteristics

| Symbol | Parameter | Typ. | Max. | Unit | Test Conditions | Note |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {sD }}$ | Diode Forward Voltage | 3.5 |  | V | $\mathrm{V}_{\text {GS }}=-5 \mathrm{~V}, \mathrm{I}_{\mathrm{F}}=5 \mathrm{~A}, \mathrm{~T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ |  |
|  |  | 3.1 |  |  | $\mathrm{V}_{\mathrm{GS}}=-2 \mathrm{~V}, \mathrm{I}_{\mathrm{F}}=5 \mathrm{~A}, \mathrm{~T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ |  |
| $\mathrm{t}_{\mathrm{rr}}$ | Reverse Recovery Time | 138 |  | ns | $\begin{aligned} & \mathrm{V}_{G S}=-5 \mathrm{~V}, \mathrm{I}_{\mathrm{F}}=10 \mathrm{~A}, \mathrm{~T}_{J}=25^{\circ} \mathrm{C} \\ & \mathrm{~V}_{\mathrm{R}}=800 \mathrm{~V}, \\ & \mathrm{~d} \mathrm{i}_{\mathrm{F}} / \mathrm{d} t=100 \mathrm{~A} / \mu \mathrm{s} \end{aligned}$ | Fig. 22 |
| $\mathrm{Q}_{\mathrm{rr}}$ | Reverse Recovery Charge | 94 |  | nC |  |  |
| $\mathrm{I}_{\text {rrm }}$ | Peak Reverse Recovery Current | 1.57 |  | A |  |  |

## Thermal Characteristics

| Symbol | Parameter | Typ. | Max. | Unit | Test Conditions | Note |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{R}_{\text {өנc }}$ | Thermal Resistance from Junction to Case | 0.66 | 0.82 | K/W |  | Fig. 7 |
| $\mathrm{R}_{\text {日cs }}$ | Case to Sink, w/ Thermal Compound | 0.25 |  |  |  |  |
| $\mathrm{R}_{\text {өJA }}$ | Thermal Resistance From Junction to Ambient |  | 40 |  |  |  |

## Gate Charge Characteristics

| Symbol | Parameter | Typ. | Max. | Unit | Test Conditions | Note |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Qgs | Gate to Source Charge | 11.8 |  | nC | $\begin{aligned} & V_{D D}=800 \mathrm{~V}, V_{G S}=0 / 20 \mathrm{~V} \\ & I_{D}=10 \mathrm{~A} \\ & \text { Per JEDEC24 pg } 27 \end{aligned}$ | Fig. 12 |
| $\mathrm{Q}_{\mathrm{gd}}$ | Gate to Drain Charge | 21.5 |  |  |  |  |
| $\mathrm{Q}_{9}$ | Gate Charge Total | 47.1 |  |  |  |  |

## Typical Performance



Figure 1. Typical Output Characteristics $\mathrm{T}_{3}=25^{\circ} \mathrm{C}$


Figure 3. Normalized On-Resistance vs. Temperature


Figure 5. On-Resistance vs. Gate Voltage


Figure 2. Typical Output Characteristics $\mathrm{T}_{\mathrm{J}}=135^{\circ} \mathrm{C}$


Figure 4. On-Resistance vs. Drain Current


Figure 6. Typical Transfer Characteristics

## Typical Performance



Figure 7. Transient Thermal Impedance (Junction - Case) with Duty Cycle


Figure 9. Power Dissipation Derating Curve


Figure 11. Gate Threshold Voltage vs. Temperature


Figure 8. Safe Operating Area


Figure 10. Continuous Current Derating Curve


Figure 12. Typical Gate Charge Characteristics ( $25^{\circ} \mathrm{C}$ )

## Typical Performance



Figure 13A and 13B. Typical Capacitances vs. Drain Voltage at $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}$ and $\mathrm{f}=1 \mathrm{MHz}$


Figure 14. Typical $\mathrm{C}_{\text {oss }}$ Stored Energy


Figure 16. Resistive Switching Times vs. External $\mathrm{R}_{\mathrm{G}}$ at $\mathrm{V}_{\mathrm{DD}}=400 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=10 \mathrm{~A}$


Figure 15. Typical Unclamped Inductive Switching Waveforms Showing Avalanche Capability


Figure 17. Resistive Switching Times vs. External $\mathrm{R}_{\mathrm{G}}$ at $\mathrm{V}_{\mathrm{DD}}=800 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=10 \mathrm{~A}$

## Typical Performance



Figure 18. Clamped Inductive Switching Energy vs. Drain Current (Fig. 20)


Figure 19. Clamped Inductive Switching Energy vs. Junction Temperature (Fig 20)


Figure 20. Clamped Inductive Switching Waveform Test Circuit


Figure 21. Switching Test Waveforms for Transition times


Fig 22. Body Diode Recovery Test


Fig 24. Unclamped Inductive Switching Test Circuit


Fig 23. Body Diode Recovery Waveform


$$
E_{A}=1 / 2 L \times I_{D}^{2}
$$

Fig 25. Unclamped Inductive Switching waveform for Avalanche Energy

## ESD Ratings

| ESD Test | Total Devices Sampled | Resulting Classification |
| :---: | :---: | :---: |
| ESD-HBM | All Devices Passed 1000 V | $2(>2000 \mathrm{~V})$ |
| ESD-MM | All Devices Passed 400V | C $(>400 \mathrm{~V})$ |
| ESD-CDM | All Devices Passed 1000V | IV $(>1000 \mathrm{~V})$ |

## Package Dimensions

Package TO-247-3


## Recommended Solder Pad Layout



| Part Number | Package | Marking |
| :---: | :---: | :---: |
| CMF10120D | TO-247-3 | CMF10120 |

TO-247-3

 $2002 / 95 / E C$ on the restriction of the use of certain hazardous substances in electrical and electronic equipment (RoHS), as amended through April $21,2006$.

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